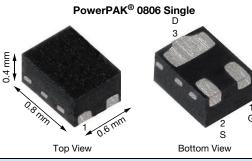
# SiUD412ED

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**Vishay Siliconix** 



PRODUCT SUMMARY	
V <sub>DS</sub> (V)	12
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_GS$ = 4.5 V	0.34
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_GS$ = 2.5 V	0.4
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS}$ = 1.8 V	0.55
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS}$ = 1.5 V	1.2
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS}$ = 1.2 V	2.5
Q <sub>g</sub> typ. (nC)	0.47
I <sub>D</sub> (A)	0.5 <sup>a, f</sup>
Configuration	Single

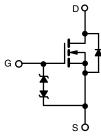
## **FEATURES**

N-Channel 12 V (D-S) MOSFET

- TrenchFET<sup>®</sup> power MOSFET
- Ultra small 0.8 mm x 0.6 mm outline
- Ultra thin 0.4 mm max. height
- Typical ESD protection 1500 V (HBM)
- 1.2 V rated R<sub>DS(ON)</sub>
- 100% R<sub>a</sub> tested
- · Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

### APPLICATIONS

- Load switch
- · High speed switching
- DC/DC converters
- · Battery-operated and mobile devices



N-Channel MOSFET

ORDERING INFORMATION	
Package	PowerPAK 0806
Lead (Pb)-free and halogen-free	SiUD412ED-T1-GE3

<b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_A = 25 \text{ °C}$ , unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V <sub>DS</sub>	12	v	
Gate-source voltage		V <sub>GS</sub>	± 5		
Continuous drain current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C		0.5 <sup>a, f</sup>		
	T <sub>A</sub> = 70 °C		0.5 <sup>a, f</sup>	Ī	
	T <sub>A</sub> = 25 °C		0.5 <sup>b</sup>	†	
	T <sub>A</sub> = 70 °C		0.5 <sup>b</sup>	А	
Pulsed drain current (t = 100 µs)		I <sub>DM</sub>	1.5		
Continuous source-drain diode current	T <sub>A</sub> = 25 °C		0.5 <sup>a, f</sup>	Ī	
	T <sub>A</sub> = 70 °C	I <sub>S</sub>	0.37 <sup>b</sup>	1	
Maximum power dissipation	T <sub>A</sub> = 25 °C		1.25 ª		
	T <sub>A</sub> = 70 °C		0.8 <sup>a</sup>	14/	
	T <sub>A</sub> = 25 °C	P <sub>D</sub>	0.37 <sup>b</sup>	W	
	T <sub>A</sub> = 70 °C	1	0.24 <sup>b</sup>	1	
Operating junction and storage temperature range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Soldering recommendations (peak temperature) <sup>c</sup>			260		

### THERMAL RESISTANCE RATINGS

PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient <sup>a, d</sup>	t ≤ 5 s	R <sub>thJA</sub>	80	100	°C/W	
Maximum junction-to-ambient b, e	t ≤ 5 s	R <sub>thJA</sub>	265	335	0/11	

#### Notes

a. Surface mounted on 1" x 1" FR4 board with full copper, t = 5 s. b. Surface mounted on 1" x 1" FR4 board with minimum copper, t = 5 s.

c. Refer to IPC / JEDEC® (J-STD-020), no manual or hand soldering.

d. Maximum under steady state conditions is 135 °C/W.

Maximum under steady state conditions is 400 °C/W. e.

Package limited. f.

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PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static				•	•	•	
Drain-source breakdown voltage	V <sub>DS</sub>	$V_{GS} = 0 V, I_D = 250 \mu A$	12	-	-	V	
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$		-	9	-	mV/°C	
V <sub>GS(th)</sub> temperature coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA	-	-1	-		
Gate-source threshold voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$	0.35	-	0.9	V	
Gate-source leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 4.5 \text{ V}$	-	-	± 10		
Zero gate voltage drain current		$V_{DS} = 12 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	1	μA	
	IDSS	$V_{DS} = 12 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$	-	-	10		
On-state drain current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \geq 5 \text{ V},  V_{GS} = 4.5 \text{ V}$	1	-	-	Α	
		$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 0.5 \text{ A}$	-	0.27	0.34		
		$V_{GS} = 2.5 \text{ V}, \text{ I}_{D} = 0.2 \text{ A}$	-	0.31	0.4	Ω	
Drain-source on-state resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 1.8 V, I <sub>D</sub> = 0.1 A	-	0.37	0.55		
		$V_{GS} = 1.5 \text{ V}, \text{ I}_{D} = 0.1 \text{ A}$	-	0.42	1.2		
		$V_{GS} = 1.2 \text{ V}, \text{ I}_{D} = 0.05 \text{ A}$	-	0.55	2.5		
Forward transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 6 \text{ V}, \text{ I}_{D} = 0.5 \text{ A}$	-	1.6	-	S	
Dynamic <sup>b</sup>							
Input capacitance	C <sub>iss</sub>		-	21	-	pF	
Output capacitance	C <sub>oss</sub>	$V_{DS}$ = 6 V, $V_{GS}$ = 0 V, f = 1 MHz	-	13	-		
Reverse transfer capacitance	C <sub>rss</sub>		-	7	-		
Total gate charge	Qg	$V_{DS} = 6 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 0.5 \text{ A}$	-	0.47	0.71		
Gate-source charge	Q <sub>gs</sub>		-	0.04	-	nC	
Gate-drain charge	Q <sub>gd</sub>	$V_{DS} = 6 V, V_{GS} = 4.5 V, I_D = 0.5 A$	-	0.09	-	1	
Gate resistance	R <sub>g</sub>	f = 1 MHz	3	15	30	Ω	
Turn-on delay time	t <sub>d(on)</sub>		-	2	5		
Rise time	tr	$V_{DD} = 6 V, R_{L} = 12 \Omega, I_{D} \cong 0.5 A,$	-	20	40	- ns	
Turn-off delay time	t <sub>d(off)</sub>	$V_{GEN}$ = 4.5 V, $R_g$ = 1 $\Omega$	-	17	35		
Fall time	t <sub>f</sub>		-	10	20		
Drain-Source Body Diode Characterist	ics						
Continuous source-drain diode current	I <sub>S</sub>	T <sub>A</sub> = 25 °C -	-	-	0.5 <sup>c</sup>	^	
Pulse diode forward current	I <sub>SM</sub>		-	-	1.5	- A	
Body diode voltage	V <sub>SD</sub>	$I_{\rm S} = 0.5$ A, $V_{\rm GS} = 0$ V	-	0.7	1.2	V	
Body diode reverse recovery time	t <sub>rr</sub>		-	15	30	ns	
Body diode reverse recovery charge	Q <sub>rr</sub>		-	3	6	nC	
Reverse recovery fall time	ta	$I_F = 0.5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, \text{T}_J = 25 ^\circ\text{C}$	-	12.5	-	ns	
Reverse recovery rise time	t <sub>b</sub>		-	2.5	-		

Notes

a. Pulse test; pulse width  $\leq 300~\mu s,~duty~cycle \leq 2~\%.$ 

b. Guaranteed by design, not subject to production testing.

c. Surface mounted on  $1" \times 1"$  FR4 board with full copper, t = 5 s.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

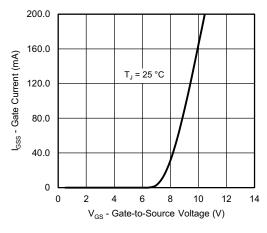
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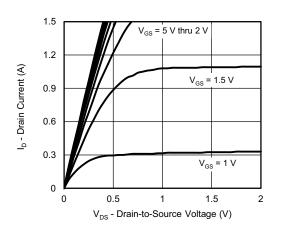
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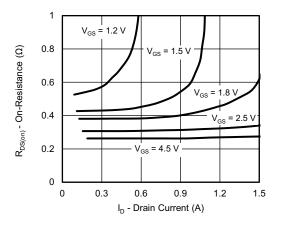
# TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



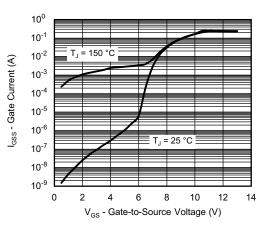
Gate-Current vs. Gate-Source Voltage



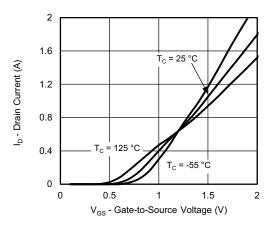
**Output Characteristics** 



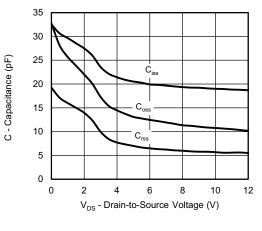
On-Resistance vs. Drain Current and Gate Voltage



Gate-Current vs. Gate-Source Voltage



**Transfer Characteristics** 



Capacitance

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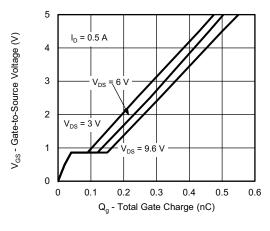
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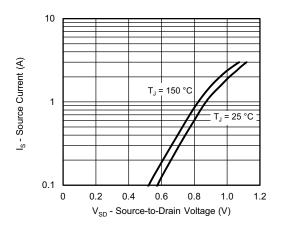


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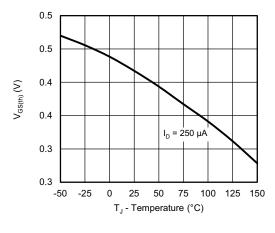
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



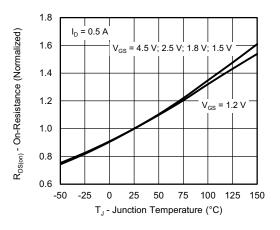
Gate Charge



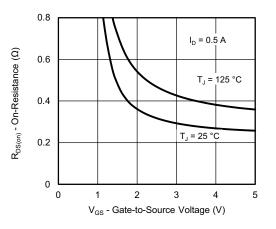
Source-Drain Diode Forward Voltage



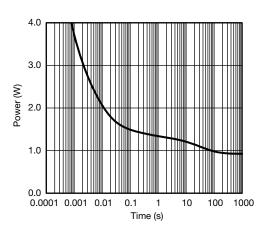
**Threshold Voltage** 



**On-Resistance vs. Junction Temperature** 



On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

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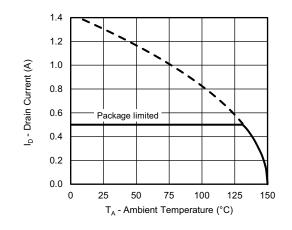
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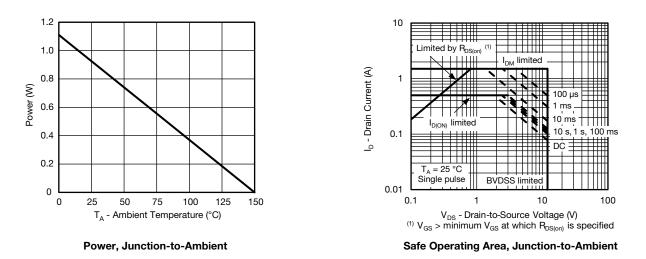


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## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating <sup>a</sup>



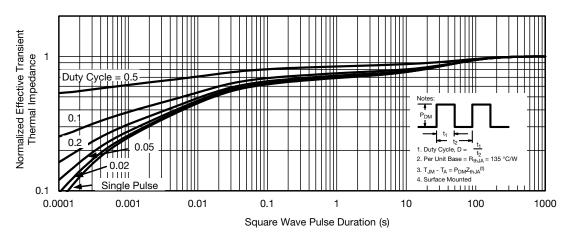
Note

a. The power dissipation P<sub>D</sub> is based on T<sub>J</sub> max. = 25 °C, using junction-to-ambient thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

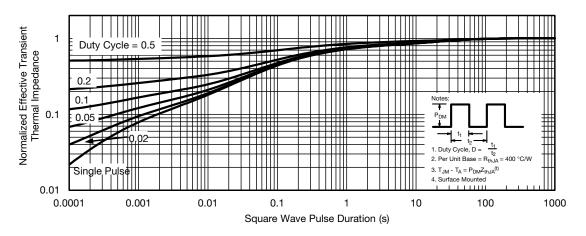


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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient (on 1" x 1" FR4 board with maximum copper)



Normalized Thermal Transient Impedance, Junction-to-Ambient (on 1" x 1" FR4 board with minimum copper)

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="http://www.vishay.com/ppg?70300">www.vishay.com/ppg?70300</a>.



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